## Applicant(s)/Patent Under Application/Control No. Reexamination 10/627,316 **NEILL ET AL.** Notice of References Cited Art Unit Examiner Page 1 of 1 2821 Chuc D Tran **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 02-2004 257/659 Mathews et al. US-6,686,649 Α 01-2003 361/686 Sutton et al. В US-6,504,710 10-1997 Kunert, Steven R. 361/816 US-5,682,299 С US-2003/0125070 07-2003 Wagner et al. 455/550 D US-6,801,170 10-2004 Forrester et al. 343/702 Ε F US-6,023,147 02-2000 Cargin et al. 320/114 US-G US-Н US-US-US-Κ L US-US-М **FOREIGN PATENT DOCUMENTS** Date **Document Number** ` Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Х